9-28-04

IFU PTO/SB/21 (08-00)

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BOX004-1C US

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Application Number 10/722,724

Filing Date November 25, 2003

First Inventor Peter G. Borden

Confirmation No. 7346

Group Art Unit 2877

Examiner Name Rosenberger

Attorney Docket No.

ENCLOSURES (check all that apply)								
×	Fee Transmittal Form (1 page in duplicate)	Assignment Papers (for an Application)		After Allowance Communication to Group				
Fee Attached Check		Drawing(s)		Appeal Communication to Board of Appeals and Interferences				
	Amendment / Reply	Licensing-related Papers		Appeal Communication to Group (Appeal Notice, Brief, Reply Brief)				
	After Final	Petition		Proprietary Information				
	Affidavits/declarations	Petition to Convert to a Provisional Application						
	Extension of Time Request	Power of Attorney, Revocation of Previous Powers; And Statement Under 37 CFR 3.73(b)	Power of Attorney, Revocation of Previous Powers; And Statement Other Enclosure(s) (ple					
		Terminal Disclaimer		RETURN RECEIPT POSTCARD				
	Express Abandonment Request	Request for Refund		PTO 1449 (1 page) Copies of Fourteen cited				
×	Information Disclosure Statement (2 pages)	CD, Number of CD(s)						
	Certified Copy of Priority Document(s)	Remarks						
	This is a Response to Missing Parts/ Incomplete Application under 37 CFR	Please charge Deposit Account 50-2263 for any underpaid fee.						
,	1.52 or 1.53 Copy of Notice To File Missing							
	Parts (2 pages)							
SIGNATURE OF APPLICANT, ATTORNEY OR AGENT								
Firm	Omkar K. Sun	/adevara (Reg. No. 36,320)						
or	· ·	Patent Group LLP						
Indiv	idual Name 2350 Mission	College Boulevard, Suite 360						
L	Santa Clara, California 95054							
Signature S. Omkor								
Date Sept 27, 2004								
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Modified PTO/SB/17 (09-00)

Approved for use through 10/31/2002. OMB 0651-0032

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	0.0	Complete if Known			
FEE TRANSMITT	Application Number	10/722,724			
OFFEOR FY 2004	Filing Date	November 25, 2003			
(3)		First Named Inventor	Peter G. Borden		
SEP 2 7 2004 3		Group Art Unit	2877		
Ratent fees are subject to annual revision.		Examiner Name	Rosenberger		
Refer to fees are subject to annual revision. POTAL AMOUNT OF PAYMENT	(\$) 180.00	Attorney Docket No	BOX004-1C US		

METHOD OF PAYMENT	FEE CALCULATION (continued)							
1. The Commissioner is hereby authorized underpayment and credit any overpayme	3. ADDITIONAL FEES							
Deposit Account Number		Large Fee Code	Entity Fee (\$)	Small Fee Code	Entity Fee (\$)	Fee D	escription	Fee Paid
Deposit Account Silicon Valley Patent Group LL	P							
Name Name	<u> </u>	1051	130	2051	65		rge - late filing fee or oath	
Charge Any Additional Fee Required Under 37	CFR 1.16 and 1.17	1052	50	2052	25		irge - late provisional filing cover sheet	
Applicant claims small entity status. See 37 C	FR 1.27	1053	130	1053	130	Non-E	nglish specification	
2. 🕱 Payment Enclosed:		1812	2,520	1812	2,520		ng a request for ex parte nination	
☑ Check ☐ Credit Card ☐ Money	Order Other	1804	920*	1804	920*		sting publication of SIR prior miner action	
FEE CALCULATION		1805	1,840*	1805	1,840*		sting publication of SIR after ner action	
1. BASIC FILING FEE		1251	110	2251	55		ion for reply within first month	
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1002 340 2002 170 Design filing		1401	330 330	2401	165		of Appeal	
1003 530 2003 265 Plant filing fe 1004 770 2004 385 Reissue filin		1402 1403	290	2402 2403	165 145	-	a brief in support of an appeal st for oral hearing	
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	`	1452	110	2452	55	Petitio	oing n to revive - unavoidable	
SUBTOTAL (1)	(\$)0.00	1453	1,300	2453	650		n to revive - unintentional	
2. EXTRA CLAIM FEES		1501	1,330	2501	665		ssue fee (or reissue)	
Extrà Fee from Claims below	Fee Paid	1502	480	2502	240	Design	issue fee	
Total Claims - ** X 18	= \$	1503	640	2503	320	Plant is	ssue fee	
Independent - ** x 86	= \$	1460	130	1460	130	Petitio	ns to the Commissioner	
Multiple Dependent 0 140	= \$0	1807	50	1807	50	Proces	sing fee for provisional ations	
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	endent claims, if not paid	1801	770	2801	375	Reque	ned (37 CFR § 1.129(b)) st for Continued Examination	
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" or number previously paid, if greater; For reissues, s	*Reduced by Basic Filing Fee Paid SUBTOTAL (3) (\$) 180.00				3) 180.00			
SUBMITTED BY						Complete (if applicable)		
Name (Print/Type) Omkar K. St		stration No mey/Agen		36,320		Telephone (408) 983	2-8200 ext. 3	
Signature S. On	skar						Date Septemb	er 27, 2004



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Peter G. Borden; Jiping Li; Inventors:

Assignee: Applied Materials, Inc.

Title: Measuring A Property Of A Layer In A Multilayered Structure

Serial No.: 10/722,724 Filing Date: November 25, 2003

Examiner: Rosenberger Group Art Unit: 2877

Confirmation No: Docket No.: BOX004-1C US 7346

> Santa Clara, California September 27, 2004

MAIL STOP AMENDMENT COMMISSIONER FOR PATENTS P.O. BOX 1450 ALEXANDRIA, VA 22313-1450

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR §1.97(c)

Dear Sir:

Pursuant to 37 C.F.R. § 1.56, §1.97 and §1.98, the Applicants submit for consideration in the above-identified patent application the document listed on the accompanying Form PTO-1449. Copies of the documents 121-134 are submitted herewith. The remaining documents are not attached hereto, because these documents are issued patents which are readily available in the U.S. Patent and Trademark Office. The Examiner is requested to make these documents of record.

This Information Disclosure Statement is submitted pursuant to 37 CFR §1.97(c) as it is after receipt of a first Office Action on the merits but before mailing of a final Action or Notice of Allowance. Accordingly, a fee is required pursuant to 37 CFR §1.17(p). A Fee Transmittal form (PTO/SB/17) is attached to this submission.

Applicants would appreciate the Examiner initialing and returning the Form PTO-1449, indicating that the information has been considered and made of record herein.

The information contained in this Information Disclosure Statement is to the best of my knowledge and is not to be construed as a representation that: (i) a complete search has been made; (ii) additional information material to the examination of this application does not

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Application No. 10/722,724

exist; (iii) the information, protocols, results and the like reported by third parties are accurate or enabling; or (iv) the above information constitutes prior art to the subject invention.

Via Express Mail Label No. EV 448 866 784 US Respectfully submitted,

Omkar K. Suryadevara Attorney for Applicants Reg. No. 36,320

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U.S. Department of Commerce Patent and Trademark Office
SEP 27 2004
INFORMATION DISCLOSURE STATEMENT BY APPLICANT
(Use several sheets if necessary)

Application No.:	10/722,724
Filing Date:	November 25, 2003
First Named Inventor:	Peter G. Borden
Group Art Unit:	2877
Examiner Name:	Rosenberger
Confirmation No.:	7346
Attorney Docket No.:	BOX004-IC US

	·.		U.S. P	atent Documents					
*Examiner Intials		Document Number				Filing Date if Appropriate			
	118.	6,211,961	4/3/03	Maris	356	432			
	119.	6,268,916	7/31/01	Lee et al.	356	432			
	120.	4,571,685	2/18/86	Komoshida	364	468			
	•	•	Foreign	Patent Documents					
							Tran	slation	
		Document	Date	Country	Class	Subclass	Yes	No	
	121.	0 718 595	20.12.95	Europe	G01B	11/06			
	122.	99/64880	16.12.99	WO	G01R	31/26			
-		Other A	rt (Including Auth	or, Title, Date, Pertinent Pa	ges, Etc.)	_l			
	Paquin, "Properties of Metals", Handbook of Optics, Vol. II, McGraw-Hill, Inc. (month unavailable), 19t pp. 35.3-35.7						, 1995,		
124. Schroder, "Semiconductor Material and Device Characterization", John Wiley & unavailable), 1990, pp2-20, 84-85, 232-235, 304-306, 364, 367-374, 378-383.					& Sons, Inc.	(month			
	126.	J. Opsal, "High Resolution Thermal Wave Measurements and Imaging of Defects and Damage in Electronic Materials" Photoacoustic and Photothermal Phenomena II, Springer Series in Optical Sciences, Vol. 62, Springer Verlag Berlin, Heidelberg, 1990.							
Rosencwaig, "Thermal Wave Characterization and Inspection of Semicor Chapter 5 (pp. 97-135) of Photoacoustic and Thermal Wave Phenomena i (month unavailable) 1987 127. Constantinos Christofides "Photomodulated Thermoreflectance Investigat Wafers," Microelectronic Engineering, 40 (1998), 251-261. 128. Bristow, Thomas C. and Dag Lindquist, "Surface Measurements With A Instrument", Interferometric Metrology, SPIE vol. 816, August 1987, pag									
							rski-Pro	filing	
	129.	"Process Monitoring System", Quantox Product Brochure, 3 pages, published prior to March 1, 2002							
	130.	International Search Report PCT/ US99/12999							
	131.	International Search Report PCT/US03/06239							
	132.	International Searc	ternational Search Report PCT/US01/07475						
133. International Search Report PCT/US03/06379									

Examiner:	Date Considered:							

^{*} Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication with applicant.